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| Notice of References Cited | Application/Control No. 10/582,581 | | Applicant(s)/Patent Under Reexamination HASHIMOTO ET AL. | |
| | Examiner CHRISTOPHER BECCIA | | Art Unit 3775 | Page 1 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------------|----------------|
| * | A | US-3,150,470 A | 09-1964 | BARRON LEE H | 451/532 |
| * | B | US-4,464,836 A | 08-1984 | Hissa, Robert E. | 30/92 |
| * | C | US-4,709,699 A | 12-1987 | Michael et al. | 606/177 |
| * | D | US-5,395,374 A | 03-1995 | Miller et al. | 606/74 |
| * | E | US-5,536,270 A | 07-1996 | Songer et al. | 606/74 |
| * | F | US-5,545,168 A | 08-1996 | Burke, Dennis W. | 606/74 |
| * | G | US-5,752,420 A | 05-1998 | Connors, David R. | 83/54 |
| * | H | US-5,868,748 A | 02-1999 | Burke, Dennis W. | 606/74 |
| * | I | US-5,919,190 A | 07-1999 | VanDusseldorp, Gregg A. | 606/46 |
| * | J | US-5,961,526 A | 10-1999 | Chu et al. | 606/113 |
| * | K | US-5,971,994 A | 10-1999 | Fritzsche, Gernod | 606/113 |
| * | L | US-6,077,268 A | 06-2000 | Farris et al. | 606/74 |
| * | M | US-6,364,885 B1 | 04-2002 | Kilpela et al. | 606/74 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/582,581 | | Applicant(s)/Patent Under Reexamination HASHIMOTO ET AL. | |
| | Examiner CHRISTOPHER BECCIA | | Art Unit 3775 | Page 2 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-6,530,936 B1 | 03-2003 | Yun, Yeong Seok | 606/167 |
| * | B | US-6,743,228 B2 | 06-2004 | Lee et al. | 606/47 |
| * | C | US-2004/0137827 A1 | 07-2004 | Hench et al. | 451/041 |
| * | D | US-6,881,131 B2 | 04-2005 | Parsells et al. | 451/53 |
| * | E | US-2005/0216023 A1 | 09-2005 | Aram et al. | 606/086 |
| * | F | US-2006/0030854 A1 | 02-2006 | Haines, Timothy G. | 606/088 |
| * | G | US-7,556,630 B2 | 07-2009 | Molz et al. | 606/74 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
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FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
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| | X | |

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